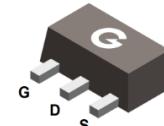
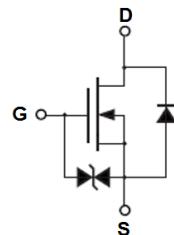


## Features

- ESD improved capability
- Depletion-mode ( normally-on)

**HF**

**SOT-89**

## Mechanical Data

- Case: SOT-89
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208

## Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BL126E	SOT-89	1000 pcs / Tape & Reel	126

## Maximum Ratings (@ $T_c = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSX}$	600	V
Gate -Source Voltage	$V_{GSS}$	$\pm 20$	V
Continuous Drain Current ( $T_c = 25^\circ\text{C}$ )	$I_D$	0.04	A
Continuous Drain Current ( $T_c = 70^\circ\text{C}$ )		0.032	A
Pulsed Drain Current	$I_{DM}$	0.16	A
Gate Source ESD(HBM-C = 100pF, R = 1.5kΩ)	$V_{ESD(G-S)}$	300	V

## Thermal Characteristics

Parameter	Symbol	Value	Unit
Power Dissipation ( $T_A = 25^\circ\text{C}$ )	$P_D$	1	W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	50	°C/W
Thermal Resistance Junction-to-Air *1	$R_{\theta JA}$	125	°C/W
Operating Junction Temperature Range	$T_J$	-55 ~ +150	°C
Storage Temperature Range	$T_{STG}$	-55 ~ +150	°C

**Electrical Characteristics** (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSX}}$	Drain-to-Source Breakdown Voltage	$V_{\text{GS}} = -5\text{V}$ , $I_D = 250\mu\text{A}$	600	-	-	V
$I_{\text{D(OFF)}}$	Off-state Drain-to-Source Current	$V_{\text{DS}} = 600\text{V}$ , $V_{\text{GS}} = -5\text{V}$	-	-	0.1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-to-Source Leakage Current	$V_{\text{GS}} = \pm 20\text{V}$ , $V_{\text{DS}} = 0\text{V}$	-	-	$\pm 10$	$\mu\text{A}$
<b>On Characteristics</b>						
$I_{\text{DSS}}$	Saturated Drain-to-Source Current	$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 25\text{V}$	12	-	-	mA
$R_{\text{DS(ON)}}$	Drain-to-Source On-resistance <sup>*2</sup>	$V_{\text{GS}} = 0\text{V}$ , $I_D = 3\text{mA}$	-	-	700	$\Omega$
		$V_{\text{GS}} = 10\text{V}$ , $I_D = 16\text{mA}$	-	-	800	$\Omega$
$V_{\text{GS(OFF)}}$	Gate-to-Source Cut-off Voltage	$V_{\text{DS}} = 3\text{V}$ , $I_D = 8\mu\text{A}$	-2.7	-2	-1.0	V
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}} = 50\text{V}$ , $I_D = 10\text{mA}$	-	17	-	$\text{mS}$
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{GS}} = -5\text{V}$ $V_{\text{DS}} = 25\text{V}$ $f = 1.0\text{MHz}$	-	50	-	pF
$C_{\text{oss}}$	Output Capacitance		-	4.53	-	
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	1.08	-	
<b>Switching Characteristics</b>						
$t_{\text{d(ON)}}$	Turn-on Delay Time <sup>*3</sup>	$V_{\text{DD}} = 300\text{V}$ $V_{\text{GS}} = -5\text{V} \sim 7\text{V}$ $R_G = 6\Omega$ $I_D = 10\text{mA}$	-	9.9	-	ns
$t_r$	Turn-on Rise Time <sup>*3</sup>		-	55.8	-	
$t_{\text{d(OFF)}}$	Turn-Off Delay Time <sup>*3</sup>		-	56.4	-	
$t_f$	Turn-Off Fall Time <sup>*3</sup>		-	136	-	
$Q_G$	Total Gate-Charge	$V_{\text{DD}} = 400\text{V}$ $V_{\text{GS}} = -5\text{V} \sim 5\text{V}$ $I_D = 10\text{mA}$	-	1.14	-	nC
$Q_{\text{GS}}$	Gate to Source Charge		-	0.5	-	
$Q_{\text{GD}}$	Gate to Drain (Miller) Charge		-	0.37	-	
<b>Source-Drain Diode Characteristics</b>						
$V_{\text{SD}}$	Diode Forward Voltage <sup>*2</sup>	$I_{\text{SD}} = 16\text{mA}$ , $V_{\text{GS}} = -5\text{V}$	-	-	1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_{\text{SD}} = 10\text{mA}$ , $V_{\text{GS}} = 0\text{V}$ $dI/dt = 100\text{A}/\mu\text{s}$	-	243	-	ns
$Q_{\text{rr}}$	Reverse Recovery Charge		-	636	-	nC
<b>Gate-source Zener Diode</b>						
$V_{\text{GSO}}$	Gate-source Breakdown Voltage	$I_{\text{GS}} = \pm 1\text{mA}$ (Open Drain)	20	-	-	V

Notes:

- The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper
- The data tested by pulsed, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$
- Guaranteed by design, not subject to production

## Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

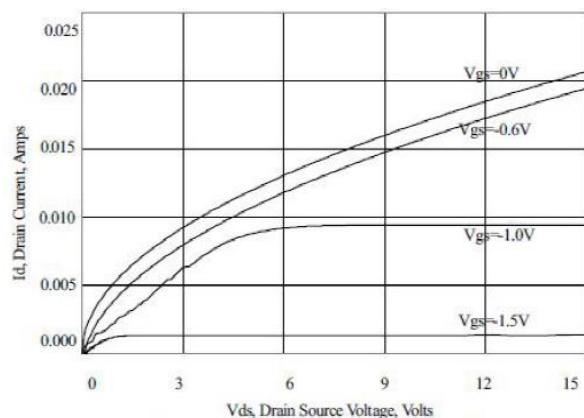


Fig 1 Typical Output Characteristics

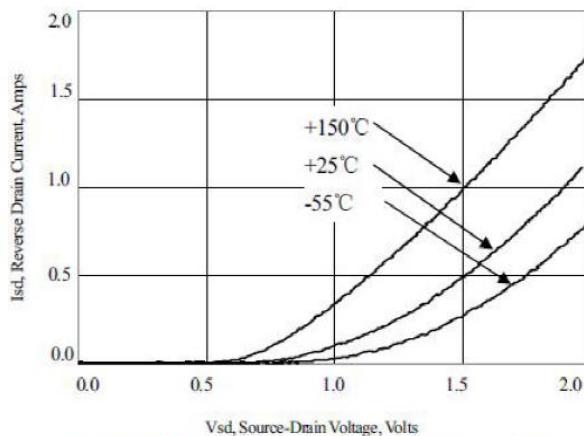


Fig 2 Body-Diode Characteristics

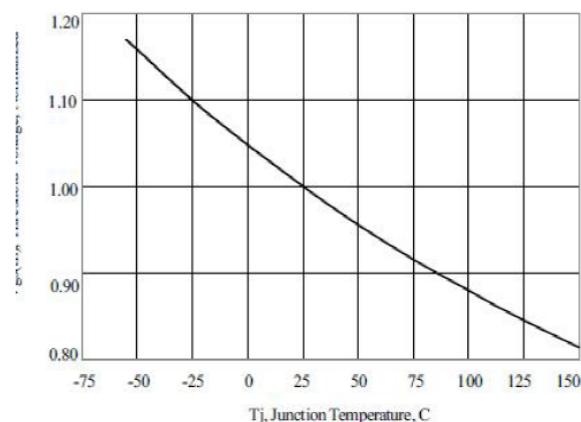


Fig 3 Normalized  $V_{gs(\text{th})}$  vs. Junction Temperature

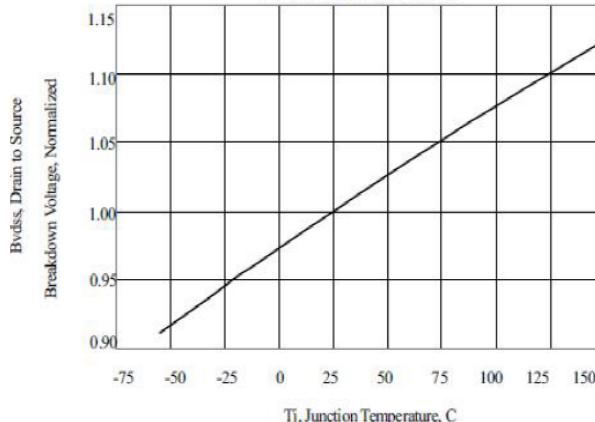


Fig 4 Normalized Breakdown Voltage  
vs. Junction Temperature

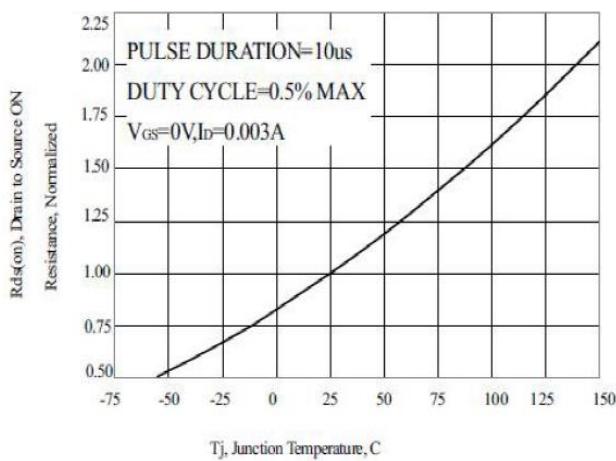


Fig 5 Normalized On-Resistance vs. Junction  
Temperature

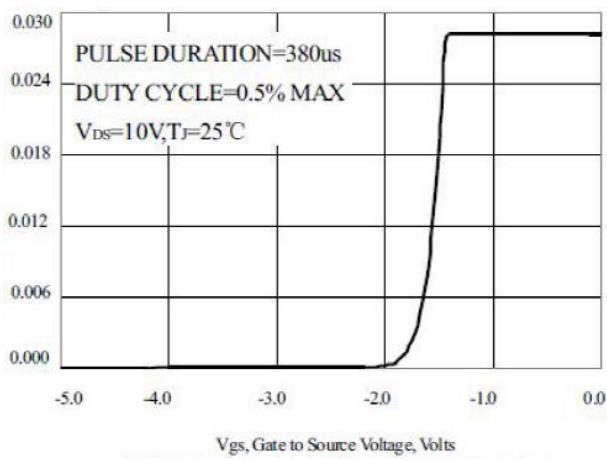


Fig 6 Transfer Characteristics

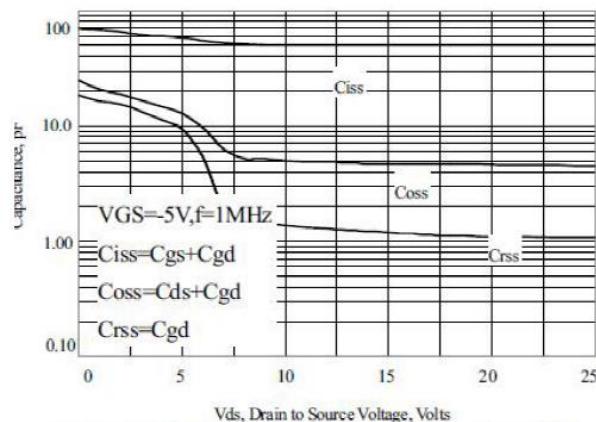


Fig 7 Capacitance Characteristics

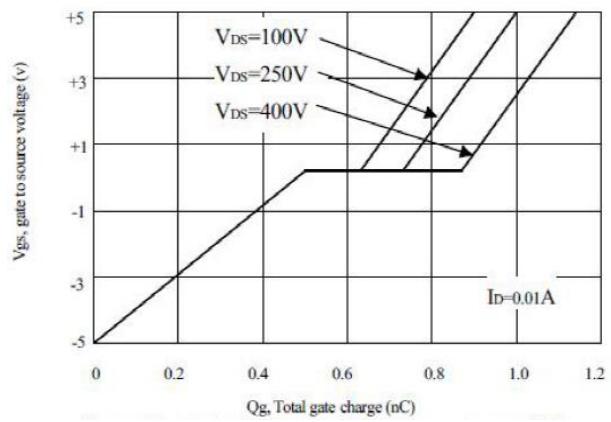
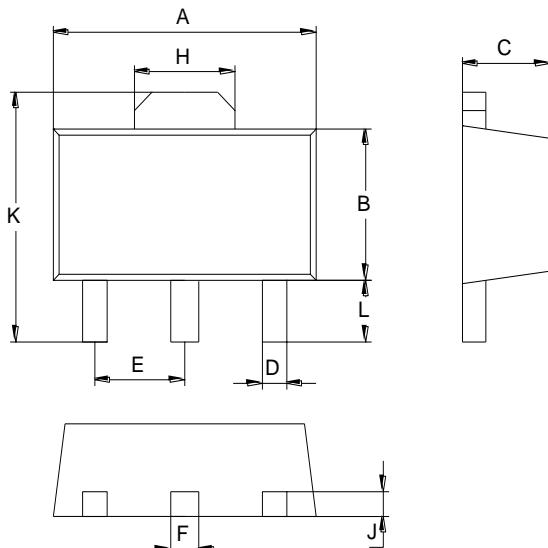


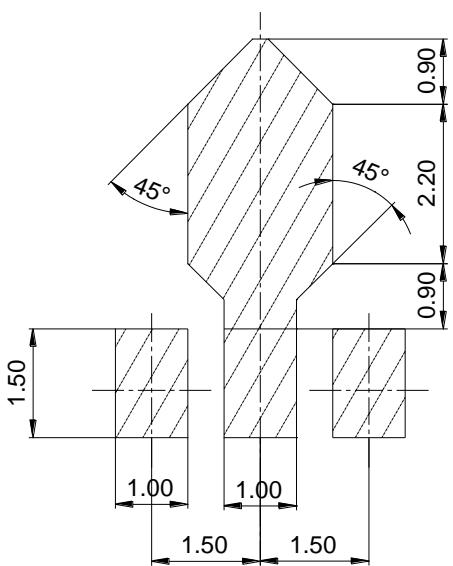
Fig 8 Gate-Charge Characteristics

### Package Outline Dimensions (Unit: mm)



SOT-89		
Dimension	Min.	Max.
A	4.30	4.70
B	2.25	2.65
C	1.30	1.70
D	0.30	0.50
E	1.40	1.60
F	0.38	0.58
H	1.60	1.80
J	0.30	0.50
L	0.90	1.10
K	3.95	4.35

### Mounting Pad Layout (Unit: mm)

**SOT-89**


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